

Data sheet acquired from Harris Semiconductor SCHS205I

# CD54HC4049, CD74HC4049, CD54HC4050, CD74HC4050

# High-Speed CMOS Logic Hex Buffers, Inverting and Non-Inverting

February 1998 - Revised February 2005

#### Features

- Typical Propagation Delay: 6ns at  $V_{CC}$  = 5V,  $C_L$  = 15pF,  $T_A$  = 25°C
- High-to-Low Voltage Level Converter for up to V<sub>I</sub> = 16V
- Fanout (Over Temperature Range)
  - Standard Outputs...... 10 LSTTL Loads
  - Bus Driver Outputs ...... 15 LSTTL Loads
- Wide Operating Temperature Range . . . –55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
  - 2V to 6V Operation
  - High Noise Immunity:  $N_{IL}$  = 30%,  $N_{IH}$  = 30% of  $V_{CC}$  at  $V_{CC}$  = 5V

#### **Pinout**

CD54HC4049, CD54HC4050 (CERDIP) CD74HC4049, CD74HC4050 (PDIP, SOIC, SOP, TSSOP) TOP VIEW

<u>4049</u>	<u>4050</u>	 <u>4050</u>	<u>4049</u>
$v_{\text{CC}}$	V <sub>CC</sub> 1	16 NC	NC
<u>1Y</u>	1Y 2	15 6Y	6Y
1A	1A 3	14 6A	6A
<b>2</b> Y	2Y 4	13 NC	NC
2A	2A 5	12 5Y	<b>5Y</b>
<b>3Y</b>	3Y 6	11 5A	5A
3A	3A 7	10 4Y	<b>4Y</b>
GND	GND 8	9 4A	4A

#### Description

The 'HC4049 and 'HC4050 are fabricated with high-speed silicon gate technology. They have a modified input protection structure that enables these parts to be usedas logic level translators which convert high-level logic to a low-level logic while operating off the low-level logic supply. For example, 15-V input pulse levels can be down-converted to 0-V to 5-V logic levels. The modified input protection structure protects the input from negative electrostatic discharge. These parts also can be used as simple buffers or inverters without level translation. The 'HC4049 and 'HC4050 are enhanced versions of equivalent CMOS types.

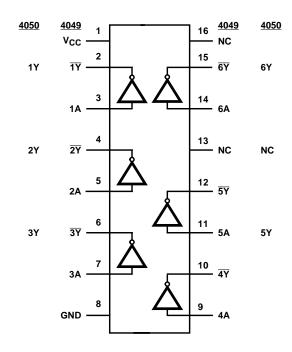
#### **Ordering Information**

PART NUMBER	TEMP. RANGE (°C)	PACKAGE
CD54HC4049F3A	-55 to 125	16 Ld CERDIP
CD54HC4050F3A	-55 to 125	16 Ld CERDIP
CD74HC4049E	-55 to 125	16 Ld PDIP
CD74HC4049M	-55 to 125	16 Ld SOIC
CD74HCT4050MT	-55 to 125	16 Ld SOIC
CD74HC4049M96	-55 to 125	16 Ld SOIC
CD74HC4049NSR	-55 to 125	16 Ld SOP
CD74HC4049PW	-55 to 125	16 Ld TSSOP
CD74HC4049PWR	-55 to 125	16 Ld TSSOP
CD74HC4049PWT	-55 to 125	16 Ld TSSOP
CD74HC4050E	-55 to 125	16 Ld PDIP
CD74HC4050M	-55 to 125	16 Ld SOIC
CD74HC4050MT	-55 to 125	16 Ld SOIC
CD74HC4050M96	-55 to 125	16 Ld SOIC
CD74HC4050NSR	-55 to 125	16 Ld SOP
CD74HC4050PW	-55 to 125	16 Ld TSSOP
CD74HC4050PWR	-55 to 125	16 Ld TSSOP
CD74HC4050PWT	-55 to 125	16 Ld TSSOP

NOTE: When ordering, use the entire part number. The suffixes 96 and R denote tape and reel. The suffix T denotes a small-quantity reel of 250.

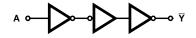
# CD54HC4049, CD74HC4049, CD54HC4050, CD74HC4050

# Functional Diagram

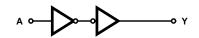


# Logic Diagrams

HC4049



HC4050



## CD54HC4049, CD74HC4049, CD54HC4050, CD74HC4050

#### **Absolute Maximum Ratings**

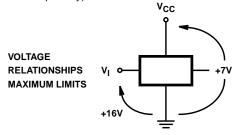
DC Supply Voltage, V <sub>CC</sub> 0.5V to 7V
Input Voltage Range
DC Input Diode Current, I <sub>IK</sub>
For V <sub>I</sub> < -0.5V20mA
DC Output Diode Current, I <sub>OK</sub>
For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$
DC Output Source or Sink Current per Output Pin, IO
For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$
DC V <sub>CC</sub> or Ground Current, I <sub>CC or</sub> I <sub>GND</sub>

#### **Operating Conditions**

Temperature Range (T <sub>A</sub> )–55°C to 125°C
Supply Voltage Range, V <sub>CC</sub>
HC Types2V to 6V
HCT Types
DC Input Voltage, V <sub>1</sub> 0V to 15V
DC Output Voltage, VO
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

#### **Thermal Information**

Package Thermal Impedance, θ <sub>JA</sub> (see Note 1):
E (PDIP) Package
M (SOIC) Package73°C/W
NS (SOP) Package 64°C/W
PW (TSSOP) Package 108 <sup>o</sup> C/W
Maximum Junction Temperature (Hermetic Package or Die) 175°C
Maximum Junction Temperature (Plastic Package) 150°C
Maximum Storage Temperature Range –65°C to 150°C
Maximum Lead Temperature (Soldering 10s)300°C
(SOIC - Lead Tips Only)



CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

#### **DC Electrical Specifications**

		TES CONDI		V <sub>CC</sub>	25°C			-40°C 1	го 85°С	–55°C TO 125°C		
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES												
High Level Input Voltage	V <sub>IH</sub>	-	-	2	1.5	-	-	1.5	-	1.5	-	V
				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input	V <sub>IL</sub>	-	-	2	-	-	0.5	-	0.5	-	0.5	V
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	2	1.9	-	-	1.9	-	1.9	-	V
Voltage CMOS Loads			-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
OWIGO Educa			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Voltage TTL Loads			-5.2	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
OMOO Eddds			0.02	6	-	-	0.1	-	0.1	-	0.1	V
Low Level Output			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Voltage TTL Loads			5.2	6	-	-	0.26	_	0.33	i	0.4	V
Input Leakage Current	II	V <sub>CC</sub> or GND	-	6	-	-	±0.1	-	±1	-	±1	μА
		15	-	6	-	-	±0.5	-	±5	-	±5	]

#### CD54HC4049, CD74HC4049, CD54HC4050, CD74HC4050

## DC Electrical Specifications (Continued)

			TEST CONDITIONS			25°C		–40°C 1	O 85°C		C TO 5°C	
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	6	-	-	2	-	20	-	40	μА

#### Switching Specifications Input t<sub>r</sub>, t<sub>f</sub> = 6ns

		TEST		25°C		–40°C TO 85°C		−55°C TO 125°C			
PARAMETER	SYMBOL	CONDITIONS	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES											
Propagation Delay,	t <sub>PLH</sub> , t <sub>PHL</sub>	$C_L = 50pF$	2	-	-	85	-	105	-	130	ns
nA to nY HC4049 nA to nY HC4050			4.5	-	-	17	-	21	-	26	ns
11// 10 111 110-1000			6	-	-	14	-	18	-	22	ns
		C <sub>L</sub> = 15pF	5	-	6	-	-	-	-	-	ns
Transition Times (Figure 1)	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	2	-	-	75	-	95	-	110	ns
			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Input Capacitance	Cl	-	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 2, 3)	C <sub>PD</sub>	-	5	-	35	-	-	-	-	-	pF

#### NOTES:

- 2.  $C_{PD}$  is used to determine the dynamic power consumption, per gate. 3.  $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$  where  $f_i$  = Input Frequency,  $C_L$  = Output Load Capacitance,  $V_{CC}$  = Supply Voltage.

#### Test Circuit and Waveform

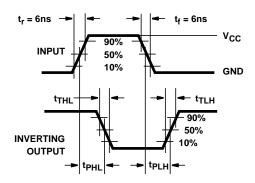


FIGURE 1. HC AND HCU TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

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#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8681901EA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8681901EA CD54HC4049F3A	Samples
5962-8682001EA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8682001EA CD54HC4050F3A	Samples
CD54HC4049F3A	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8681901EA CD54HC4049F3A	Samples
CD54HC4050F3A	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8682001EA CD54HC4050F3A	Samples
CD74HC4049E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4049E	Samples
CD74HC4049EE4	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4049E	Samples
CD74HC4049M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4049M	Samples
CD74HC4049M96G4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4049M	Samples
CD74HC4049NSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4049M	Samples
CD74HC4049PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4049	Samples
CD74HC4050E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4050E	Samples
CD74HC4050M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4050M	Samples
CD74HC4050NSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4050M	Samples
CD74HC4050PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4050	Samples
CD74HC4050PWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4050	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.

#### **PACKAGE OPTION ADDENDUM**

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(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF CD54HC4049, CD54HC4050, CD74HC4049, CD74HC4050:

Catalog: CD74HC4049, CD74HC4050

Military: CD54HC4049, CD54HC4050

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



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#### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS KO P1 BO W Cavity A0

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC4049M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4049NSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD74HC4049PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4050M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4050NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD74HC4050PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC4049M96	SOIC	D	16	2500	340.5	336.1	32.0
CD74HC4049NSR	SO	NS	16	2000	356.0	356.0	35.0
CD74HC4049PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
CD74HC4050M96	SOIC	D	16	2500	340.5	336.1	32.0
CD74HC4050NSR	SO	NS	16	2000	356.0	356.0	35.0
CD74HC4050PWR	TSSOP	PW	16	2000	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD74HC4049E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC4049E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC4049EE4	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC4049EE4	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC4050E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC4050E	N	PDIP	16	25	506	13.97	11230	4.32

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